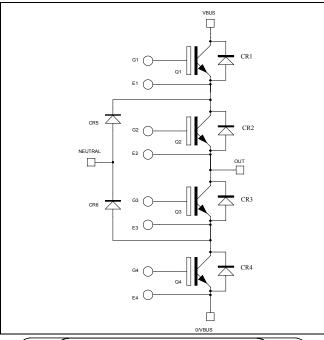
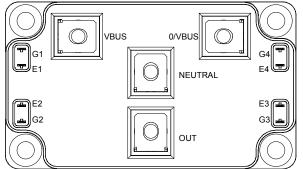


Three level inverter Trench + Field Stop IGBT4 Power Module







Application

- Solar converter
- Uninterruptible Power Supplies

Features

- Trench + Field Stop IGBT 4 Technology
 - Low voltage drop
 - Low leakage current
 - Low switching losses
 - Soft recovery parallel diodes
 - Low diode VF
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
 - Symmetrical design
 - M5 power connectors
- High level of integration

Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

Q1 to Q4 Absolute maximum ratings

X - ** X				
Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage		1200	V
Ţ	Continuous Collector Current	$T_c = 25^{\circ}C$	305	
I_{C}	Continuous Collector Current	$T_c = 80^{\circ}C$	240	A
I_{CM}	Pulsed Collector Current	$T_c = 25$ °C	400	
V_{GE}	Gate – Emitter Voltage		±20	V
P_{D}	Maximum Power Dissipation	$T_c = 25$ °C	1000	W
RBSOA	Reverse Bias Safe Operating Area	$T_i = 150^{\circ}C$	400A @ 1150V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



All ratings @ $T_j = 25$ °C unless otherwise specified

Q1 to Q4 Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V ; V_{CE} = 1200V$				2	mA
V _{CE(sat)}	Collector Emitter Saturation Voltage	$V_{GE} = 15V$ $I_{C} = 200A$	$T_j = 25^{\circ}C$ $T_i = 150^{\circ}C$		1.8	2.2	V
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 5 \text{ mA}$		5	5.8	6.5	V

Q1 to Q4 Dynamic Characteristics

_	Characteristic	Test Conditions	1	Min	Typ	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$			12.3		
Coes	Output Capacitance				0.8		nF
C_{res}	Reverse Transfer Capacitance	f = 1MHz			0.69		
Q_{G}	Gate charge	V _{GE} =±15V			1.7		μС
$T_{d(on)}$	Turn-on Delay Time		Inductive Switching (25°C)				
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$			30		ns
T _{d(off)}	Turn-off Delay Time	$V_{CE} = 600V$ $I_{C} = 200A$			340		
$T_{\rm f}$	Fall Time	$R_G = 3.6\Omega$			80		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15V$ $V_{CE} = 600V$			170		ns
T _r	Rise Time				40		
$T_{d(off)}$	Turn-off Delay Time	$I_C = 200A$			450		110
$T_{\rm f}$	Fall Time	$R_G = 3.6\Omega$			170		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$	$T_J = 25^{\circ}C$		10.4		mJ
Oli	2 23	$V_{CE} = 600V$	$T_{\rm J} = 150^{\circ}{\rm C}$		21		
E_{off}	Turn-off Switching Energy	$I_C = 200A$ $R_G = 3.6\Omega$	$T_J = 25^{\circ}C$		11		mJ
			$T_{\rm J} = 150^{\circ}{\rm C}$		18.6		
I_{SC}	Short circuit current	$V_{GE} \le 15V ; V_{CC} = 900V$ $t_p \le 10 \mu s ; T_i = 150 ^{\circ} C$			1000		A
R_{thJC}	Junction to Case Thermal Resistance					0.15	°C/W

CR1 to CR4 diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	V _R =1200V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 400	μΑ
I_{F}	DC Forward Current		$Tc = 80^{\circ}C$		180		A
17	Diada Famyand Valtaga	$I_{\rm F} = 150A$	$T_i = 25^{\circ}C$		1.7	2.2	V
V_{F}	Diode Forward Voltage	$V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.65		V
+	Davana Dagayany Tima		$T_j = 25$ °C		155		ng
t_{rr}	Reverse Recovery Time		$T_j = 150$ °C		300		ns
Q _{rr}	Reverse Recovery Charge	$I_F = 150A$ $V_R = 600V$	$T_j = 25$ °C		14.6		μС
Qrr	Reverse Recovery Charge	$di/dt = 3800 A/\mu s$	$T_{i} = 150^{\circ}C$		30.4		μС
Б	D	αι, αι 30001 μ3	$T_j = 25$ °C		5.2		an I
E _{rr}	Reverse Recovery Energy		$T_{\rm j} = 150^{\circ}{\rm C}$		11		mJ
R_{thJC}	Junction to Case Thermal Resistance		_			0.32	°C/W

2 - 8



CR5 & CR6 diode ratings and characteristics

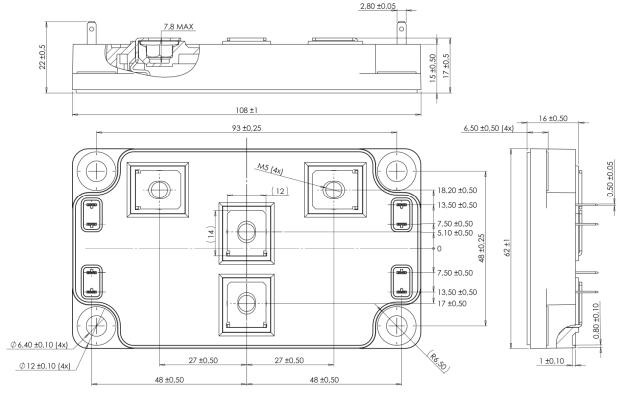
Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	V _R =1200V	$T_i = 25$ °C $T_i = 150$ °C			150 400	μΑ
I_F	DC Forward Current		$Tc = 80^{\circ}C$		240		A
W	Diede Fernyand Voltage	$I_F = 200A$	$T_i = 25^{\circ}C$		1.9	2.4	V
V _F	V_F Diode Forward Voltage $V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.85		V	
t	Reverse Recovery Time	T - 200 A	$T_j = 25$ °C		155		ns
t_{rr}	Reverse Recovery Time		$T_j = 150$ °C		300		115
Qrr	Reverse Recovery Charge	$V_{R} = 600V$	$T_j = 25$ °C		18.6		μC
Vп	Reverse Recovery Charge		$T_{i} = 150^{\circ}C$		39		μС
Б	В	αναι 1000/1/μ5	$T_j = 25$ °C		8.2		ana I
E _{rr}	Reverse Recovery Energy		$T_{\rm j} = 150^{\circ}{\rm C}$		16		mJ
R_{thJC}	Junction to Case Thermal Resistance					0.25	°C/W

Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz			4000			V
$T_{\rm J}$	Operating junction temperature range Storage Temperature Range Operating Case Temperature					175	
T_{STG}						125	°C
$T_{\rm C}$						100	
Torque	Mounting torque	To heatsink	M6	3		5	NI
Torque	Mounting torque	For terminals	M5	2		3.5	N.m
Wt	Package Weight					300	g



SP6 Package outline (dimensions in mm)

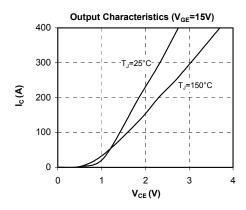


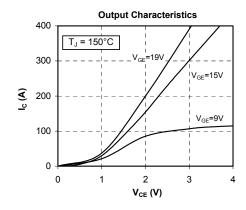
See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

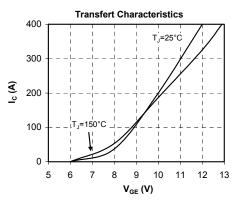
Q1 to Q4 Typical performance curve

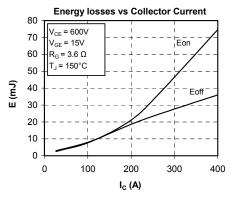
Operating Frequency vs Collector Current 100 Fmax, Operating Frequency (kHz) V_{CE}=600V D=50% 80 $R_G=3.6 \Omega$ T,=150℃ 60 Tc=75℃ Hard switching 40 20 50 100 150 200 250 300 $I_c(A)$

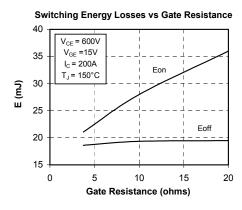


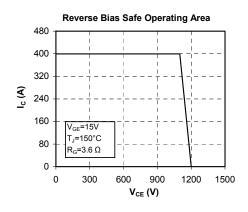


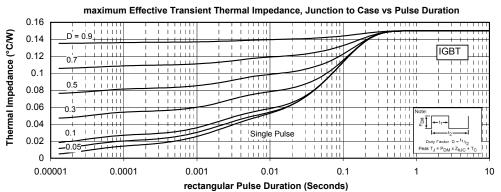






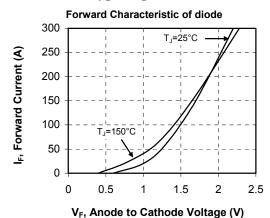


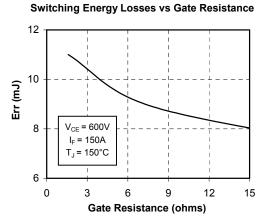


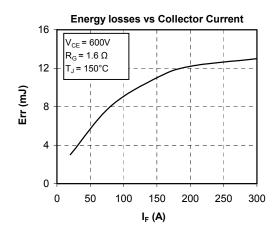




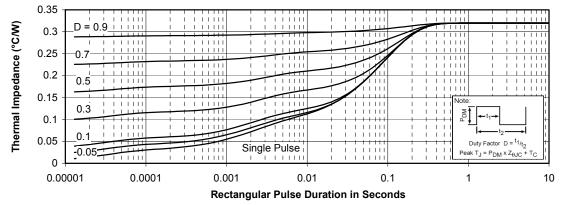
CR1 to CR4 Typical performance curve





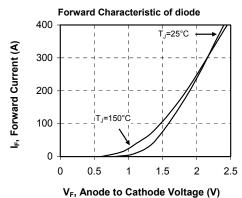




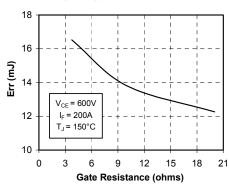


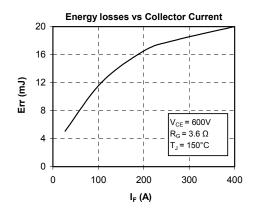


CR5 & CR6 Typical performance curve

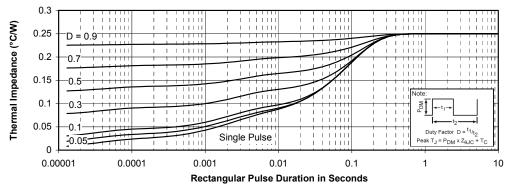








maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration





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